

Schedule

OPUS Precision Instruments Pte Ltd
Blk 10 Ubi Crescent
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UBI Techpark Lobby B
Singapore 408564

Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 1 of 19

FIELD OF TESTING : Calibration and Measurement

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
A. DIMENSIONAL METROLOGY		
1. Bevel Protractor i Straightness & Parallelism ii Indication of Error	BS 1685 : 2008 Opus in-house procedure OPCP-01A, R2	0.0001 inch 5 min
2. Bore Gauge 0 – 2 mm (Plunger Travel)	JIS B 7515 : 1982 Opus in-house procedure OPCP-02A, R2	2 µm
3. Vernier Caliper Up to 1000 mm	JIS B 7507 : 1993 Opus in-house procedure OPCP-03A, R2	12 µm
4. Caliper Checker up to 600mm Parallelism	Opus in-house procedure OPCP-04A, R2	1.3 µm 1.2 µm
5. Dial Caliper Gauge / Dial Thickness Gauge Up to 50 mm	Opus in-house procedure OPCP-05A, R2	1 µm
6. Dial Gauge Tester up to 50mm	Opus in-house procedure OPCP-06A, R2	0.5 µm
7. Dial Indicator up to 10 mm above 10 mm to 20 mm above 20 mm to 50 mm above 50 mm to 80 mm above 80 mm to 100 mm	JIS B 7503 : 2011 DIN 879-1 : 1999 OPCP in-house procedure OPCP-07A, R2	0.6 µm 1.0 µm 1.4 µm 2.0 µm 2.7 µm

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 2 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
8. Dial Test Indicator Up to 1 mm	JIS B 7533 : 2015 Opus in-house procedure OPCP-08A, R2	0.6 μ m
9. Digimatic Indicator 0 to 30 mm 0 to 60 mm	Opus in-house procedure OPCP-09A, R2	0.8 μ m 2.0 μ m
10. Feeler Gauge Up to 1 mm	BS 957 : 2008 Opus in-house procedure OPCP-10A, R2	1.0 μ m
11. Granite Surface Plate (Lab / on-site) Up to 3000 mm i Overall Flatness ii Variation from local flatness	BS 817 : 2008 Opus in-house procedure OPCP-12A, R2	2.0 μ m 1.0 μ m
12. Linear Height Gauge (Lab / on-site) Up to 900mm	Opus in-house procedure OPCP-13A, R2	3 μ m
13. Vernier Height Gauge up to 600 mm	Opus in-house procedure OPCP-14A, R2	10 μ m
14. Height Setting Micrometer up to 300mm	ISO 7863 : 1984 Opus in-house procedure OPCP-15A, R2	1.4 μ m
15. Holtest Up to 63 mm	DIN 863 Part 4 : 1999 & Opus in-house procedure OPCP-16A, R2	1.8 μ m
16. External Micrometer Up to 100 mm Above 100 mm to 300 mm Above 300 mm to 500 mm Above 500 mm to 1000mm	Opus in-house procedure OPCP-17A, R2	1 μ m 2 μ m 3 μ m 5 μ m

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 3 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
17. Internal & Stick Micrometer i. Micrometer Head - Up to 25 mm ii. Extension Rod – Up to 300 mm	BS 959 : 2008 Opus in-house procedure OPCP-18A, R2	2 µm 4 µm
18. Depth Micrometer Up to 300mm	BS 6468 : 2008 Opus in-house procedure OPCP-19A, R2	2 µm
19. Pin Gauge / Plug Gauge Up to 25 mm Up to 50 mm Up to 100 mm	BS 969 : 2008 ,as a guide Opus in-house procedure OPCP-20A, R2	0.5 µm 1.2 µm 1.2 µm
20. Plain Ring Gauge 3 mm to 30 mm Above 30 mm to 100 mm Above 100mm to 150mm	BS 969 : 2008, as a guide Opus in-house procedure OPCP-21B, R2	0.8 µm 1.2 µm 2.6 µm
21. Profile Projector (Lab / on-site) up to 200 mm	JIS B 7184 : 1999 Opus in-house procedure OPCP-22A, R2	3 µm
22. Setting Rod for External Micrometer Up to 500 mm Above 500 mm to 1000 mm	Opus in-house procedure OPCP-24B, R2	1.2 µm 2.0 µm
23. Thread Plug Gauge Up to 50 mm i. Pitch & Major Diameter ii. Pitch iii. Flank Angle	ISO 1502 : 1996 ANSI / ASME B1.2 : 1983 BS 919 Pt 1 to Pt 4 : 2007 BS 3643 Pt 1 & 2 : 2007 BS 1580 Pt 1 & 3 : 2007 Opus in-house procedure OPCP-26A, R2	1 µm 3 µm 3 min
24. Toolmaker Microscope (Lab / on-site)	JIS B 7153 : 1995 Opus in-house procedure OPCP-27A, R2	3 µm

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 4 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
25. Universal Length Measuring Up to 100 mm	Opus in-house procedure OPCP-31A, R2	0.5 µm
26. Vernier Depth Gauge Up to 600 mm	BS 6365: 2008 Opus in-house procedure OPCP-32A, R2	10 µm
27. Thickness Foils (Plastic) Up to 1100 µm	Opus in-house procedure OPCP-36A, R2	0.6 µm
28. Co-ordinate Measuring Machine 40 x 710 x 420 mm	ISO 10360-2 2009 as a guide Opus in-house procedure OPCP-25A	8.0 µm
B. FORCE MEASUREMENT		
1. Push / Pull Gauge up to 500 gf above 0.5 kgf to 5 kgf above 5 kgf to 10 kgf above 10 kgf to 50 kgf	Opus in-house procedure OPCP-23C R2	0.2 gf 0.002 kgf 0.01 kgf 0.02 kgf
2. Torque Gauge / Torque Meter up to 1.5 kgf.cm up to 3.6 kgf.cm up to 9 kgf.cm up to 15 kgf.cm	Opus in-house procedure OPCP-28A R2	0.004 kgf.cm 0.01 kgf.cm 0.02 kgf.cm 0.1 kgf.cm
3. Weighing Scale (Lab/ On-site) up to 310 g, Resolution: 0.0001g up to 620 g, Resolution: 0.001g up to 5.2 kg, Resolution: 0.01g up to 30 kg, Resolution: 1g up to 100 kg, Resolution: 10g up to 150 kg, Resolution: 20g	Opus in-house procedure OPCP-30A R2	0.0018 g 0.003 g 0.05 g 1 g 10 g 20 g

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 5 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
<p>C. PRESSURE INSTRUMENTS (Lab & On-Site)</p> <p>1. Pressure Measuring Devices Pneumatic Pressure Gauges Chart/Pen recorders Digital Indicators Manometers Data loggers Calibrators Oil free & Oxygen Gauges Oil Pressure Gauges</p> <p>0 to 30 psi 0 to 300 psi 0 to 1000 psi 0 to 3000 psi 0 to 10000 psi 0 to 30000 psi</p> <p>2. Pressure Switches (Pneumatic Service/ Oil free & Oxygen Service/ Hydraulic Oil)</p> <p>0 to 30 psi 0 to 300 psi 0 to 1000 psi 0 to 3000 psi 0 to 10000 psi 0 to 30000 psi</p>	<p>Opus in-house procedure OPCP-033A R3</p> <p>Opus in-house procedure OPCP-034A R2</p>	<p>0.07 % of F.S 0.03 % of F.S 0.03 % of F.S 0.03 % of F.S 0.03 % of F.S 0.29 % of F.S</p> <p>0.07 % of F.S 0.03 % of F.S 0.03 % of F.S 0.03 % of F.S 0.03 % of F.S 0.16 % of F.S</p>

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 6 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
<p>3. Pressure Transmitter (Pneumatic Service/ Oil free & Oxygen Service/ Hydraulic Oil)</p> <p>0 to 30 psi 0 to 300 psi 0 to 1000 psi 0 to 3000 psi 0 to 10000 psi 0 to 30000 psi</p>	Opus in-house procedure OPCP-037A R2	<p>0.12 % of F.S 0.12 % of F.S 0.12 % of F.S 0.12 % of F.S 0.12 % of F.S 0.20 % of F.S</p>
<p>4. Pressure Transducer (Pneumatic Service/ Oil free & Oxygen Service/ Hydraulic Oil)</p> <p>0 to 30 psi 0 to 300 psi 0 to 1000 psi 0 to 3000 psi 0 to 10000 psi 0 to 30000 psi</p>	Opus in-house procedure OPCP-037A R2	<p>0.04 % of F.S 0.03 % of F.S 0.03 % of F.S 0.03 % of F.S 0.03 % of F.S 0.16 % of F.S</p>
<p>D. ELECTRICAL (Lab & Site)</p> <p>1. DC Voltage Measuring</p> <p>0 ~ 50 mV 50 ~ 100 mV 100 ~ 150 mV 150 ~ 202 mV 0.20 ~ 0.25 V 0.25 ~ 0.50 V 0.50 ~ 1.00 V 1.00 ~ 2.02 V 2.00 ~ 10.00 V 10.00 ~ 20.20 V 20 ~ 100 V 100 ~ 202 V 200 ~ 500 V 500 ~ 1000 V</p>	Opus in-house procedure OPCP-053A R2	<p>0.006 mV 0.0077 mV 0.01 mV 0.012 mV 0.000015 V 0.000024 V 0.000041 V 0.00008 V 0.00034 V 0.0007 V 0.004 V 0.008 V 0.023 V 0.04 V</p>

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 7 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
2. DC Current Measuring 0 ~ 50 μ A 50 ~ 100 μ A 100 ~ 150 μ A 150 ~ 202 μ A 0.200 ~ 0.250 mA 0.250 ~ 0.500 mA 0.500 ~ 1.000 mA 1.00 ~ 2.02 mA 2.00 ~ 10.00 mA 10.00 ~ 20.2 mA 20 ~ 100 mA 100 ~ 202 mA 0.200 ~ 1.000 A 1.000 ~ 2.020 A 2 ~ 10 A 10 ~ 20 A 20 ~ 30 A	Opus in-house procedure OPCP-049A R2	0.041 μ A 0.047 μ A 0.053 μ A 0.059 μ A 0.00007 mA 0.000093 mA 0.00014 mA 0.00024 mA 0.00093 mA 0.0016 mA 0.013 mA 0.023 mA 0.00022 A 0.00041 A 0.0051 A 0.011 A 0.1 A
3. AC Voltage Measuring 20 ~ 50 mV	Opus in-house procedure OPCP-045A R2 10 to 44 Hz 45 to 999 Hz 1 to 19.999 kHz 20 to 99.999 kHz	0.19 mV 0.063 mV 0.23 mV 2.6 mV
50 ~ 100 mV	10 to 44 Hz 45 to 999 Hz 1 to 19.999 kHz 20 to 99.999 kHz	0.3 mV 0.082 mV 0.26 mV 2.6 mV
100 ~ 150 mV	10 to 44 Hz 45 to 999 Hz 1 to 19.999 kHz 20 to 99.999 kHz	0.41 mV 0.11 mV 0.29 mV 2.6 mV
150 ~ 202 mV	10 to 44 Hz 45 to 999 Hz 1 to 19.999 kHz 20 to 99.999 kHz	0.53 mV 0.13 mV 0.33 mV 2.7 mV
0.200 ~ 0.250 V	10 to 44 Hz 45 to 999 Hz 1 to 19.999 kHz 20 to 99.999 kHz 100 to 500 kHz	0.00099 V 0.00046 V 0.0023 V 0.0038 V 0.026 V

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 8 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
0.250 ~ 0.500 V	10 to 44 Hz 45 to 999 Hz 1 to 19.999 kHz 20 to 99.999 kHz 100 to 500 kHz	0.0016 V 0.00053 V 0.0023 V 0.0044 V 0.026 V
0.500 ~ 1.000 V	10 to 44 Hz 45 to 999 Hz 1 to 19.999 kHz 20 to 99.999 kHz 100 to 500 kHz	0.0028 V 0.0007 V 0.0025 V 0.0057 V 0.027 V
1.00 ~ 2.020 V	10 to 44 Hz 45 to 999 Hz 1 to 19.999 kHz 20 to 99.999 kHz 100 to 500 kHz	0.0052 V 0.0012 V 0.0032 V 0.0085 V 0.03 V
2.00 ~ 10.00 V	40 to 44 Hz 45 to 999 Hz 1 to 19.999 kHz	0.027 V 0.0086 V 0.022 V
10.0 ~ 20.2 V	40 to 44 Hz 45 to 999 Hz 1 to 19.999 kHz	0.051 V 0.012 V 0.027 V
20.0 ~ 100 V	40 to 44 Hz 45 to 999 Hz	0.096 V 0.13 V
100 ~ 202 V	40 to 44 Hz 45 to 999 Hz	0.2 V 0.16 V
200 ~ 500 V	40 to 44 Hz 45 to 999 Hz	0.71 V 0.48 V
500 ~ 1000 V	46 to 999 Hz 1 to 10 kHz	0.76 V 2.3 V

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 9 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
4. AC Current Measuring	Opus in-house procedure OPCP-041A R2	
20 ~ 50 μ A	40 to 44 Hz 45 to 999 Hz	0.49 μ A 0.34 μ A
50 ~ 100 μ A	40 to 44 Hz 45 to 999 Hz	0.59 μ A 0.38 μ A
100 ~ 150 μ A	40 to 44 Hz 45 to 999 Hz	0.69 μ A 0.42 μ A
150 ~ 202 μ A	40 to 44 Hz 45 to 999 Hz	0.8 μ A 0.46 μ A
0.200 ~ 0.250 mA	40 to 44 Hz 45 to 999 Hz	0.0029 mA 0.00089 mA
0.250 ~ 0.500 mA	40 to 44 Hz 45 to 999 Hz	0.0032 mA 0.0011 mA
0.500 ~ 1.000 mA	40 to 44 Hz 45 to 999 Hz	0.0039 mA 0.0014 mA
1.00 ~ 2.02 mA	40 to 44 Hz 45 to 999 Hz	0.0059 mA 0.002 mA
2 ~ 10 mA	40 to 44 Hz 45 to 999 Hz	0.029 mA 0.014 mA
10 ~ 20.2 mA	40 to 44 Hz 45 to 999 Hz	0.059 mA 0.02 mA
20 ~ 100 mA	40 to 44 Hz 45 to 999 Hz	0.39 mA 0.13 mA
100 ~ 202 mA	40 to 44 Hz 45 to 999 Hz	0.59 mA 0.2 mA

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 10 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
0.200 ~ 1.000 A	40 to 44 Hz 45 to 999 Hz	0.0039 A 0.0023 A
1.000 ~ 2.02 A	40 to 44 Hz 45 to 999 Hz	0.0059 A 0.0031 A
2.000 ~ 10 A	30 to 44 Hz 45 to 99 Hz 0.10 to 1 kHz	0.039 A 0.016 A 0.041 A
10 ~ 20 A	30 to 44 Hz 45 to 99 Hz 0.10 to 1 kHz	0.053 A 0.025 A 0.075 A
20 ~ 30 A	30 to 44 Hz 45 to 99 Hz 0.10 to 1 kHz	0.077 A 0.036 A 0.11 A
5. Resistance Measuring (Passive) - 2 wire	Opus in-house procedure OPCP-038A R2	
174.00 mΩ		47 mΩ
273.00 mΩ		47 mΩ
1.24000 Ω		0.047 Ω
10.18200 Ω		0.048 Ω
100.2020 Ω		0.052 Ω
1.000218 kΩ		0.00014 kΩ
10.00050 kΩ		0.00097 kΩ
100.0005 kΩ		0.0094 kΩ
0.999919 MΩ		0.00017 MΩ
9.99726 MΩ		0.0046 MΩ
99.885 MΩ		0.59 MΩ
993.0 MΩ		12 MΩ
6. Resistance Measuring (Passive) - 4 wire	Opus in-house procedure OPCP-039A R2	
0 mΩ		5.8 mΩ
100.00 mΩ		5.8 mΩ
1.00310 Ω		0.0059 Ω
10.00681 Ω		0.007 Ω
100.00365 Ω		0.012 Ω
1.0000129 kΩ		0.000093 kΩ
10.000489 kΩ		0.00093 kΩ
100.0005 kΩ		0.0093 kΩ

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 11 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
<p>7. Capacitance Measuring</p> <p>0.9948 nF 10.1060 nF 20.0600 nF 50.280 nF 99.79 nF 1.0024 μF 10.166 μF</p>	<p>Opus in-house procedure OPCP-046A R2</p> <p>1 kHz</p>	<p>0.027 nF 0.06 nF 0.2 nF 0.3 nF 0.4 nF 0.005 μF 0.08 μF</p>
<p>8. Simulated Resistance Measuring</p> <p>0 ~ 10 Ω 10 ~ 100 Ω 0.100 ~ 1.000 kΩ 1 ~ 10 kΩ 10 ~ 100 kΩ 0.10 ~ 1 MΩ 1 ~ 10 MΩ</p>	<p>Opus in-house procedure OPCP-038A R2</p>	<p>0.093 Ω 0.093 Ω 0.00041 kΩ 0.0036 kΩ 0.035 kΩ 0.00035 MΩ 0.0036 MΩ</p>
<p>9. Frequency Measuring</p> <p>3 ~ 10 Hz 10 Hz ~ 100 Hz 100 Hz ~ 1000 Hz 1 kHz ~ 10 kHz 10 kHz ~ 100 kHz 100 kHz ~ 1000 kHz</p>	<p>Opus in-house procedure OPCP-055A R2</p>	<p>0.00024 Hz 0.0024 Hz 0.024 Hz 0.00024 kHz 0.0024 kHz 0.024 kHz</p>
<p>10. DC Current Clamp Measuring</p> <p>0.1 ~ 0.5 A 0.5 A ~ 1 A 1 ~ 10 A 10 ~ 50 A 50 ~ 100 A 100 ~ 500 A 500 ~ 1000 A 1000 ~ 1500 A</p>	<p>Opus in-house procedure OPCP-049A R2</p>	<p>0.11 A 0.12 A 0.17 A 0.4 A 0.9 A 4 A 6 A 9 A</p>
<p>11. AC Current Clamp Measuring</p> <p>0.1 ~ 0.5 A 0.5 A ~ 1 A 1 ~ 10 A 10 ~ 50 A</p>	<p>Opus in-house procedure OPCP-041A R2</p> <p>30 Hz to 60 Hz</p>	<p>0.11 A 0.12 A 0.17 A 0.5 A</p>

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 12 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
50 ~ 100 A 100 ~ 500 A 500 ~ 1000 A 1000 ~ 1500 A		0.9 A 4 A 6 A 9 A
12. Optical Tachometer Measuring (Non-Contact Tachometer) 240 ~ 1000 RPM 1000 ~ 5000 RPM 5000 ~ 10000 RPM 10000 ~ 30000 RPM 30000 ~ 60000 RPM	Opus in-house procedure OPCP-059A R2	2 RPM 2 RPM 2 RPM 2 RPM 3 RPM
13. Insulation Resistance Measuring 10 ~ 50 kΩ 50 ~ 100 kΩ 100 ~ 500 kΩ 0.50 ~ 1.00 MΩ 1 ~ 5 MΩ 5 ~ 10 MΩ 10 ~ 50 MΩ 50 ~ 100 MΩ 100 ~ 500 MΩ 500 ~ 1000 MΩ 1000 ~ 2000 MΩ	Opus in-house procedure OPCP-057A R2	0.12 kΩ 0.24 kΩ 1.2 kΩ 0.0024 MΩ 0.012 MΩ 0.35 MΩ 1.8 MΩ 3.5 MΩ 18 MΩ 36 MΩ 70 MΩ
14. Insulation Test Voltage Measuring 0 ~ 50 V 50 V ~ 100 V 100 V ~ 250 V 250 V ~ 500 V 500 V ~ 1000 V	Opus in-house procedure OPCP-058A R2	0.32 V 0.61 V 1.5 V 3 V 5.8 V
15. Continuity Resistance Measuring 1 Ω 10 Ω 19 Ω 100 Ω 190 Ω 1000 Ω	Opus in-house procedure OPCP-047A R2	0.061 Ω 0.081 Ω 0.11 Ω 0.29 Ω 0.54 Ω 2.4 Ω

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 13 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
16. DC Voltage Sourcing 0 ~ 100 mV 0.100 ~ 1 V 1 ~ 10 V 10 ~ 100 V 100 ~ 500 V 500 ~ 1000 V	Opus in-house procedure OPCP-052A R2	0.0085 mV 0.000038 V 0.00034 V 0.0052 V 0.036 V 0.06 V
17. AC Voltage Sourcing 1 ~ 100 mV 0.100 ~ 1 V 1 ~ 10 V 10 ~ 100 V 100 ~ 500 V 500 ~ 1000 V	Opus in-house procedure OPCP-044A R2 10 to 20 kHz	0.13 mV 0.0011 V 0.011 V 0.11 V 0.63 V 1.1 V
18. DC Current Sourcing 0 ~ 100 μ A 0.100 ~ 1 mA 1 ~ 10 mA 10 ~ 100 mA 100 ~ 400 mA 0.400 ~ 1 A 1 ~ 3 A 3 ~ 10 A	Opus in-house procedure OPCP-048A R2	0.088 μ A 0.00064 mA 0.0082 mA 0.064 mA 0.26 mA 0.00082 A 0.0042 A 0.02 A
19. AC Current Sourcing 20 ~ 100 μ A 0.100 ~ 1 mA 1 ~ 10 mA 10 ~ 100 mA 100 ~ 400 mA 0.400 ~ 1 A 1 ~ 3 A 3 ~ 10 A	Opus in-house procedure OPCP-040A R2 10 Hz to 1 kHz	0.25 μ A 0.0017 mA 0.026 mA 0.17 mA 0.94 mA 0.0017 A 0.0075 A 0.025 A
20. Resistance Sourcing 1 ~ 10 Ω 10 ~ 100 Ω 0.100 ~ 1 k Ω 1 ~ 10 k Ω 10 ~ 100 k Ω 0.1 ~ 1 M Ω 1 ~ 10 M Ω	Opus in-house procedure OPCP-061A R2	0.0047 Ω 0.017 Ω 0.00013 k Ω 0.0013 k Ω 0.013 k Ω 0.00013 M Ω 0.0048 M Ω

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 14 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
21. Frequency Sourcing 3 ~ 100 Hz 100 Hz ~ 1000 Hz 1 kHz ~ 10 kHz 10 ~ 100 kHz 100 kHz ~ 1000 kHz	Opus in-house procedure OPCP-054A R2	0.012 Hz 0.12 Hz 0.0012 kHz 0.012 kHz 0.12 kHz
22. DC Power Measuring 0.3 ~ 10 W 10 ~ 100 W 100 ~ 500 W 0.500 ~ 1.000 kW 1 kW ~ 12 kW	Opus in-house procedure OPCP-051A R2	0.011 W 0.2 W 0.99 W 0.0013 kW 0.01 kW
23. AC Power Measuring 0.3 ~ 10 W 10 ~ 100 W 100 ~ 500 W 0.500 ~ 1.000 kW 1 kW ~ 12 kW	Opus in-house procedure OPCP-043A R2 40 Hz to 400 Hz	0.12 W 0.64 W 1.6 W 0.0021 kW 0.016 kW
24. Timer / Stopwatch 1 s ~ 10 s 10 s ~ 60 s 60 s ~ 300 s 300 s ~ 600 s 600 s ~ 1200 s 1200 s ~ 1800 s 1800 s ~ 3000 s 3000 s ~ 3600 s 3600 s ~ 5400 s 5400 s ~ 18000 s 18000 s ~ 36000 s 36000 s ~ 54000 s	Opus in-house procedure OPCP-060A R2	0.12 s 0.12 s 0.12 s 0.12 s 0.12 s 0.13 s 0.13 s 0.15 s 0.15 s 0.17 s 0.26 s 0.36 s
25. DC High Voltage Sourcing 0 ~ 1 kV 1 ~ 5 kV 5 ~ 10 kV 10 ~ 20 kV 20 ~ 30 kV 30 ~ 40 kV	Opus in-house procedure OPCP-050A R2	0.03 kV 0.12 kV 0.24 kV 0.5 kV 0.4 kV 1 kV

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 15 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
26. AC High Voltage Sourcing 0.01 kV ~ 1 kV 1 kV ~ 5 kV 5 kV ~ 10 kV 10 kV ~ 20 kV 20 kV ~ 28 kV	Opus in-house procedure OPCP-042A R2 50 Hz	0.07 kV 0.29 kV 0.58 kV 1.2 kV 1.7 kV
27. Milli-Ohm Meter / Continuity Tester 10 mΩ 22 mΩ 30 mΩ 51 mΩ 100 mΩ 500 mΩ 1 Ω 2 Ω 5 Ω 10 Ω 20 Ω 50 Ω 100 Ω 200 Ω 500 Ω 1000 Ω	Opus in-house procedure OPCP-056A R2	0.14 mΩ 0.28 mΩ 0.36 mΩ 0.61 mΩ 1.17 mΩ 5.79 mΩ 0.0114 Ω 0.0226 Ω 0.0572 Ω 0.122 Ω 0.232 Ω 0.574 Ω 1.142 Ω 2.29 Ω 5.76 Ω 11.27 Ω
28. High Voltage Insulation Resistance Measuring 500 kΩ 1 MΩ 2 MΩ 4 MΩ 5 MΩ 10 MΩ 20 MΩ 30 MΩ 40 MΩ 50 MΩ 100 MΩ 200 MΩ 500 MΩ 1000 MΩ 2000 MΩ 5000 MΩ	Opus in-house procedure OPCP-056A R2	5.77 kΩ 0.0115 MΩ 0.0232 MΩ 0.0463 MΩ 0.0581 MΩ 0.1159 MΩ 0.233 MΩ 0.349 MΩ 0.464 MΩ 0.583 MΩ 1.156 MΩ 2.31 MΩ 5.78 MΩ 11.62 MΩ 24 MΩ 59 MΩ

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 16 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
<p>E. TEMPERATURE (Lab)</p> <p>1. Temperature Indicator/Controller, Digital Thermometer & Temperature Measuring Instruments</p> <p>Thermocouple Simulation - Type J</p> <p>-210 °C to -100 °C -100 °C to -30 °C -30 °C to 150 °C 150 °C to 760 °C 760 °C to 1200 °C</p> <p>Thermocouple Simulation - Type K</p> <p>-200 °C to -100 °C -100 °C to -25 °C -25 °C to 120 °C 120 °C to 1000 °C 1000 °C to 1370 °C</p> <p>Thermocouple Simulation - Type T</p> <p>-250 °C to -150 °C -150 °C to 0 °C 0 °C to 120 °C 120 °C to 400 °C</p> <p>Thermocouples Simulation - Type R</p> <p>-0 °C to 250 °C 250 °C to 1000 °C 1000 °C to 1760 °C</p> <p>Thermocouple Simulation - Type S</p> <p>0 °C to 250 °C 250 °C to 1000 °C 1000 °C to 1760 °C</p>	<p>(Electrical Simulation) Opus in-house procedure OPCP-062A R2 & OPCS-063A R2</p>	<p>0.38 °C 0.3 °C 0.29 °C 0.31 °C 0.35 °C</p> <p>0.42 °C 0.32 °C 0.3 °C 0.36 °C 0.41 °C</p> <p>0.78 °C 0.3 °C 0.29 °C 0.3 °C</p> <p>1 °C 0.6 °C 0.66 °C</p> <p>1 °C 0.6 °C 0.66 °C</p>

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 17 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
<p>Thermocouples Simulation - Type N</p> <p>-200 °C to -100 °C -100 °C to -25 °C -25 °C to 120 °C 120 °C to 410 °C 410 °C to 1300 °C</p> <p>Thermocouple Simulation - Type E</p> <p>-250 °C to -100 °C -100 °C to -25 °C -25 °C to 350 °C 350 °C to 650 °C 650 °C to 1000 °C</p>	(Electrical Simulation) Opus in-house procedure OPCP-064A R2	<p>0.57 °C 0.36 °C 0.33 °C 0.32 °C 0.39 °C</p> <p>0.65 °C 0.29 °C 0.29 °C 0.3 °C 0.32 °C</p>
<p>2. Temperature Calibrator / Sourcing Instruments</p> <p>Thermocouple Measuring - Type J</p> <p>-210 °C to -100 °C -100 °C to -30 °C -30 °C to 150 °C 150 °C to 760 °C 760 °C to 1200 °C</p> <p>Thermocouple Measuring - Type K</p> <p>-200 °C to -100 °C -100 °C to -25 °C -25 °C to 120 °C 120 °C to 1000 °C 1000 °C to 1370 °C</p> <p>Thermocouple Measuring - Type T</p> <p>-250 °C to -150 °C -150 °C to 0 °C 0 °C to 120 °C 120 °C to 400 °C</p>		<p>0.6 °C 0.6 °C 0.6 °C 0.5 °C 0.6 °C</p> <p>0.6 °C 0.5 °C 0.5 °C 0.6 °C 0.6 °C</p> <p>1.0 °C 0.7 °C 0.7 °C 0.5 °C</p>

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 18 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
<p>Thermocouple Measuring- Type R</p> <p>-0 °C to 250 °C 250 °C to 1000 °C 1000 °C to 1760 °C</p> <p>Thermocouple Measuring- Type S</p> <p>0 °C to 250 °C 250 °C to 1000 °C 1000 °C to 1760 °C</p> <p>Thermocouple Measuring- Type N</p> <p>-200 °C to -100 °C -100 °C to -25 °C -25 °C to 120 °C 120 °C to 410 °C 410 °C to 1300 °C</p> <p>Thermocouple Measuring- Type E</p> <p>-250 °C to -100 °C -100 °C to -25 °C -25 °C to 350 °C 350 °C to 650 °C 650 °C to 1000 °C</p>	<p>Opus in-house procedure 064A R2</p>	<p>1.7 °C 1.5 °C 1.5 °C</p> <p>1.6 °C 1.4 °C 1.3 °C</p> <p>0.9 °C 0.8 °C 0.7 °C 0.7 °C 0.8 °C</p> <p>0.8 °C 0.6 °C 0.5 °C 0.5 °C 0.5 °C</p>
<p>3. RTD Indicator / Digital Thermometer</p> <p>PRT100- 4 wire</p> <p>-100.010 °C 0.031 °C 30.034 °C 60.040 °C 99.959 °C 199.95 °C 399.85 °C 799.47 °C</p>	<p>Opus in-house procedure OPCP-065A R2</p>	<p>0.06 °C 0.03 °C 0.04 °C 0.05 °C 0.06 °C 0.08 °C 0.09 °C 0.1 °C</p>

Schedule



Certificate No. : LA-2005-0324-C

Issue No. : 16

Date : 10 January 2019

Page : 19 of 19

MEASURED QUANTITIES / INSTRUMENTS/RANGE TO BE CALIBRATED	METHOD	CALIBRATION & MEASUREMENT CAPABILITY (CMC*)
RTD Indicator / Digital Thermometer (2 wire)	Opus in-house procedure OPCP-065A R2	
PRT25		
-200 °C to 0 °C 0 °C to 800 °C		0.58 °C 0.7 °C
PRT100		
-200 °C to 0 °C 0 °C to 800 °C		0.16 °C 0.64 °C
PRT250		
-200 °C to 0 °C 0 °C to 800 °C		0.29 °C 0.35 °C
PRT500		
-200 °C to 0 °C 0 °C to 800 °C	0.12 °C 1.04 °C	
PRT1000		
-200 °C to 0 °C 0 °C to 800 °C	0.1 °C 0.52 °C	

Approved Signatories :

Mr Peter Foo) For categories A, B, C and D only.

Mr Balaji Mahalingam) For categories C, D and E only.

Mr Ravindranath Premkumar) For A3, A5, A7 - A10, A12 - A13, A16, A19 - A20, A25 and A28 only.

Note :

This laboratory is accredited in accordance with the recognised International Standard ISO/IEC 17025. A laboratory's fulfilment of the requirements of ISO/IEC 17025 means the laboratory meets both the technical competence requirements and **management system requirements** that are necessary for it to consistently deliver technically valid test results. The **management system requirements** in ISO/IEC 17025 are written in language relevant to laboratory operations and operate generally in accordance with the principles of ISO 9001.